Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	Applicant(s)/Patent under Reexamination	
10/623,174	OGAWA ET AL.		
Examiner	Art Unit		
Gina C Vu	1617		

SEARCHED				
Class	Subclass	Date	Examiner	
424	404, 401	3/14/2006	GΥ	
514	715, 724	3/14/2006	GY	
514	730,738,	3/14/2006	GY	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
424	404, 401	3/14/2006	GY	
	1			
			<u> </u>	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
West, Inventor, STN Parent: US 6620418 B1	3/14/2006	GY		